

The given failure rates refer to more than one article.  
For the valid articles please refer to the article list.

Device category 3 - electrical article

Prediction done by: pylt02

				based on	Environmental condition	MTTF in h	MTTF in a	failure rate in FIT ( $\lambda$ basis)
at	25	°C with	21,00	SN 29500	GB, GC - Ground Benign, Controlled	1.345.680	153,62	743,11865
at	40	°C with	34,25	SN 29500	GB, GC - Ground Benign, Controlled	938.429	107,13	1065,610481
at	55	°C with	100,00	SN 29500	GB, GC - Ground Benign, Controlled	313.126	35,74	3193,597982
at	60	°C with	100,00	SN 29500	GB, GC - Ground Benign, Controlled	263.934	30,13	2592,212403
at		°C with				-	-	
at		°C with				-	-	

